Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/040,466	TANABE ET AL.
Examiner	Art Unit
DANG T. TON	2666

SEARCHED				
Class	Subclass	Date	Examiner	
updated		1/4/06		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
370	400, 395.2	114/06	7.0	
		-		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Interference Searched	1/4/06	7.0